

**Search Notes**

Application/Control No.

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Examiner

Leonardo Andújar

Applicant(s)/Patent under  
Reexamination

SHEI ET AL.

Art Unit

2826

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
257/99;778 (text search only see search notes)	3/26/2007	LA